





Unbiased Supervised Contrastive Learning

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Carlo Alberto Barbano
1,2, Benoit Dufumier², Enzo Tartaglione², Marco Grangetto¹, Pietro Gori
²

¹University of Turin, ²LTCI, Telécom Paris, IP Paris









\blacktriangleright Introduction

- ▶ A Metric Approach for Contrastive Learning
- ▶ Debiasing with FairKL
- \blacktriangleright Conclusions
- ▶ References





- Aim of this work: learn representations that are invariant to biases in the data
- We study deep representation learning with a metric approach, proposing a novel contrastive loss named $\epsilon\text{-}\mathbf{SupInfoNCE}$
- We formalize how biases can affect the representations, and we propose **FairKL**, a regularization technique for learning bias-invariant representations.







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Contrastive Learning - Notation

2 A Metric Approach for Contrastive Learning

- Let $x \in X$ be a sample (anchor)
- Let x_i^+ be a positive sample (i.e. same class)
- Let x_j^- be a negative sample (i..e different class)



Figure: From Schroff *et al.* [5]







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Aim of contrastive learning methods: look for a parametric mapping function $f_{\theta}: X \to S^{d-1}$ that:

- $1. \ {\rm Maps} \ {\rm similar} \ {\rm samples} \ {\rm close} \ {\rm together} \ {\rm in} \ {\rm the} \ {\rm representation} \ {\rm space}$
- 2. Dissimilar samples further away







Contrastive Learning - Notation 2 A Metric Approach for Contrastive Learning

- $d: S^{d-1} \times S^{d-1} \to R$ is a distance function, eg. Euclidean
- d_i^+ and d_j^- shorthand notations for $d(f(x), f(x_i^+))$ and $d(f(x), f(x_j^-))$
- s denotes the [cosine] similarity, with s_i^+ and s_j^- shorthand for $s(f(x), f(x_i^+))$ and $s(f(x), f(x_j^-))$

Note

Given that $||f(x)||_2 = 1$, if we choose $d(x, y) = \frac{1}{2}||x - y||_2^2$, then we have s(x, y) = 1 - d(x, y)



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ϵ -margin

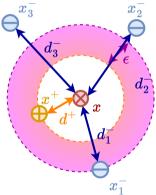
2 A Metric Approach for Contrastive Learning

Using an ϵ -margin metric learning point of view, probably the simplest formulation is looking for a mapping function f that satisfies the following condition:

$$\underbrace{s(f(x), f(x_j^-))}_{s_j^-} - \underbrace{s(f(x), f(x_i^+)}_{s_i^+} \le -\epsilon \quad \forall i, j$$

Here, $\epsilon \ge 0$ is the minimal margin between a positive sample and a negative sample (purple area)











Derivation of ϵ -SupInfoNCE 2 A Metric Approach for Contrastive Learning

• The condition $s_i^- - s_i^+ \le -\epsilon \quad \forall i, j \text{ is equivalent to } \max\{s_i^- - s_i^+\} \le -\epsilon;$







Derivation of *ϵ***-SupInfoNCE** 2 A Metric Approach for Contrastive Learning

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Derivation of *ϵ***-SupInfoNCE** 2 A Metric Approach for Contrastive Learning

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- In other words, we want to **maximize the minimal margin** between a positive and a negative sample;
- However, max is not differentiable. In order to obtain a derivable loss function, we employ *LogSumExp* (LSE), which is a smooth approximation of the max operator:

$$\arg\min_{f} \sum_{i} \max(-\epsilon, \{s_j^- - s_i^+\}) \approx \arg\min_{f} \left(\sum_{i} \log\left(\exp(-\epsilon) + \sum_{j} \exp(s_j^- - s_i^+) \right) \right)$$







Using the LSE approximation, we obtain the following loss function, which we call $\epsilon\text{-SupInfoNCE:}$

$$\mathcal{L}^{\epsilon-SupInfoNCE} = -\sum_{i} \log \left(\frac{\exp(s_i^+)}{\exp(s_i^+ - \epsilon) \sum_{j} \exp(s_j^-)} \right)$$

Alternative derivations

Please note that other derivations are possibile; some of them are shown in the full paper.







Table: Accuracy on vision datasets. SimCLR and Max-Margin results from [2]. Results denoted with * are (re)implemented with mixed precision due to memory constraints.

Dataset	Network	SimCLR	Max-Margin	SimCLR*	CE^*	SupCon^*	$\epsilon\text{-}\mathrm{SupInfoNCE}^*$
CIFAR-10	ResNet-50	93.6	92.4	91.74 ± 0.05	$94.73{\scriptstyle \pm 0.18}$	$95.64{\scriptstyle\pm0.02}$	$96.14 \scriptstyle \pm 0.01$
CIFAR-100	$\operatorname{ResNet-50}$	70.7		68.94 ± 0.12			$76.04 {\scriptstyle \pm 0.01}$
ImageNet-100	$\operatorname{ResNet-50}$	-	-	66.14 ± 0.08	$82.1 {\pm} 0.59$	$81.99{\scriptstyle\pm0.08}$	$\textbf{83.3}{\scriptstyle \pm 0.06}$







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- We employ the notion of *bias-aligned* and *bias-conflicting* samples as in [4]:







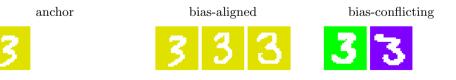
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 - 1. bias-aligned: shares the same bias attribute of the anchor. We denote it as $x^{+,b}$
 - 2. bias-conflicting: has a different bias attribute. We denote it as $x^{+,b'}$







Biases and Failure of ϵ -SupInfoNCE ³ Debiasing with FairKL

• Given an anchor x, if the bias is "strong" and easy-to-learn, a *positive* bias-aligned sample $x^{+,b}$ will probably be **closer** to the anchor x in the representation space than a *positive bias-conflicting* sample;





Biases and Failure of ϵ -SupInfoNCE ³ Debiasing with FairKL

- Given an anchor x, if the bias is "strong" and easy-to-learn, a *positive* bias-aligned sample $x^{+,b}$ will probably be **closer** to the anchor x in the representation space than a *positive* bias-conflicting sample;
- Thus, we say that there is a bias if we can identify an **ordering** on the learned representations, e.g.:

$$s_j^- + \epsilon \le s_k^{+,b'} < s_i^{+,b} \quad \forall i,k,j$$

Note

This represents the worst-case scenario, where the ordering is total (i.e., $\forall i, k, j$). Of course, there can also be cases in which the bias is not as strong, and the ordering may be partial. Furthermore, the same reasoning can be applied to negative samples (omitted for brevity).





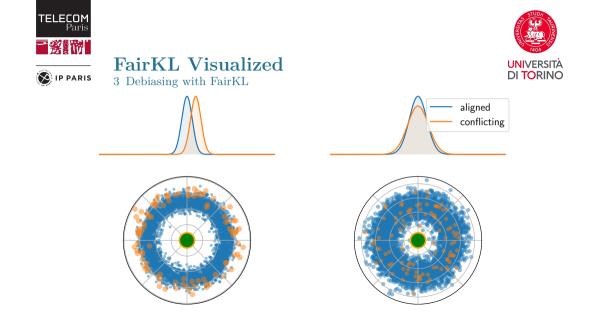
• Assuming that the similarities follow a normal distribution, we denote as $B_{+,b} \sim \mathcal{N}(\mu_{+,b}, \sigma_{+,b}^2)$ and $B_{+,b'} \sim \mathcal{N}(\mu_{+,b'}, \sigma_{+,b'}^2)$ the **distributions of similarities** of the bias-aligned and bias-conflicting samples respectively;





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- We minimize the Kullback-Leibler divergence of the two distributions with the FairKL regularization term:

$$R^{FairKL} = D_{KL}(B_{+,b}||B_{+,b'}) = \frac{1}{2} \left[\frac{\sigma_{+,b}^2 + (\mu_{+,b} - \mu_{+,b'})^2}{\sigma_{+,b'}^2} - \log \frac{\sigma_{+,b}^2}{\sigma_{+,b'}^2} - 1 \right]$$







The final obective function ${\mathcal J}$ we minimize becomes:

$$\mathcal{J} = \alpha \mathcal{L}^{\epsilon - SupInfoNCE} + \lambda \mathcal{R}^{FairKL}$$

where α and λ are positive hyperparameters.





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Results 3 Debiasing with FairKL

Table: Accuracy (%) on Biased-MNIST. Additional experiments available in the paper.

	Correlation $(\%)$						
Method	99.9	99.7	99.5	99			
CE [1]	11.8 ± 0.7	$62.5 {\pm} 2.9$	$79.5 {\pm} 0.1$	90.8 ± 0.3			
LNL [3]	18.2 ± 1.2	57.2 ± 2.2	$72.5{\pm}0.9$	$86.0 {\pm} 0.2$			
EnD [6]	59.5 ± 2.3	82.70 ± 0.3	$94.0{\pm}0.6$	$94.8 {\pm} 0.3$			
$BC+BB^*$ [1]	$30.26{\pm}11.08$	$82.83{\pm}4.17$	88.20 ± 2.27	$95.04 {\pm} 0.86$			
BB [1]	$76.8 {\pm} 1.6$	91.2 ± 0.2	$93.9{\pm}0.1$	$96.3{\pm}0.2$			
$BC+CE^*$ [1]	15.06 ± 2.22	$\underline{90.48} \pm 5.26$	$\underline{95.95}{\pm}0.11$	$\underline{97.67}{\pm}0.09$			
FairKL	$90.51{\scriptstyle \pm 1.55}$	$96.19{\scriptstyle \pm 0.23}$	$97.00{\scriptstyle\pm0.06}$	97.86 ±0.02			







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- 1. We test our method on standard debiasing benchmarks, achieving state-of-the-art results
- 2. Our metric approach allows for a clear and interpretable way of describing the behavior of different loss functions and regularizations
- 3. Furthermore, the usage of FairKL is not limited to $\epsilon\text{-SupInfoNCE}$ or contrastive losses



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- Thank you for listening!
- The code is available on github at https://github. com/EIDOSLAB/unbiased-contrastive-learning
- The full-text is available on OpenReview at https://openreview.net/pdf?id=Ph5cJSfD2XN







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